



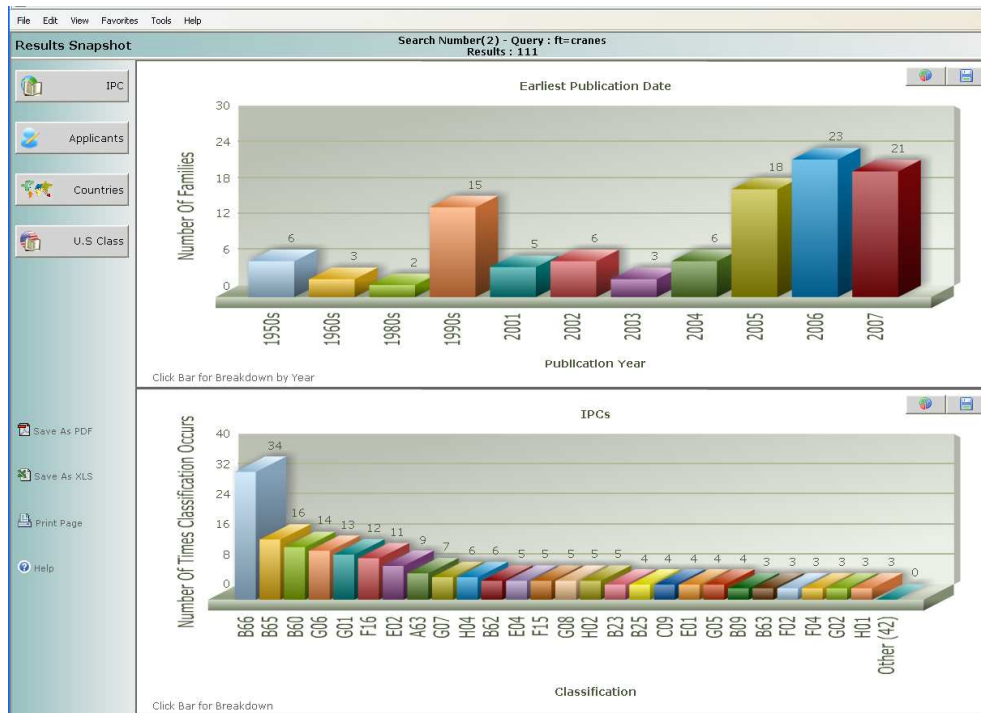
Minesoft and RWS Group announce the introduction of 'Snapshot', an instant statistical analysis tool, to PatBase

March 1st, 2009

In response to PatBase user requirements Minesoft and RWS have been working hard to develop a new type of software analysis tool which compliments the Vizpat Advanced Statistical Analysis introduced to PatBase last year.

'Snapshot', as the name suggests, offers PatBase users an instant insight into global patenting trends with respect to key areas of interest.

The sophisticated software uses graphical images which are interchangeable and interactive. Therefore, not only is it possible to change the display format but, by clicking on areas of interest within the graphical image itself, it is also possible to 'drill down' and get a further instant statistical break down of results.



Consistent with other PatBase analysis tools, PatBase "Snapshot" results can be saved or exported and images can be downloaded in a presentable format and incorporated into documents or presentations, to offer easier insight into patent information and search results.



PatBase "Snapshot" Views

